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| Notice of References Cited | Application/Control No. 10/063,424 | Applicant(s)/Patent Under Reexamination MITCHELL ET AL. | |
| | Examiner Jingge Wu | Art Unit 2623 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | A | US-6,690,832 | 02-2004 | Mitchell et al. | 382/233 |
| * | B | US-5,442,458 | 08-1995 | Rabbani et al. | 382/247 |
| * | C | US-5,717,394 | 02-1998 | Schwartz et al. | 341/51 |
| * | D | US-5,881,173 | 03-1999 | Ohmori, Masatake | 382/232 |
| * | E | US-5,903,382 | 05-1999 | Tench et al. | 359/265 |
| * | F | US-6,009,203 | 12-1999 | Liu et al. | 382/233 |
| * | G | US-6,385,341 | 05-2002 | Lisitsa et al. | 382/233 |
| * | H | US-6,591,013 | 07-2003 | Taunton, Mark | 382/233 |
| * | I | US-5,371,841 | 12-1994 | Jones, Paul W. | 345/619 |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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